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UTILITY PATENT APPLICATION TRANSMITTAL <small>(Only for new nonprovisional applications under 37 CFR 1.53(b))</small>	Attorney Docket No.	193337US2
	First Inventor or Application Identifier	Jerzy M. LEMANCZYK, et al.
	Title	DEVICE FOR MEASURING CHARACTERISTICS OF AN ELECTROMAGNETIC FIELD, PARTICULARLY FOR THE RADIATION DIAGRAM OF AN ANTENNA

APPLICATION ELEMENTS <small>See MPEP chapter 600 concerning utility patent application contents</small>	ADDRESS TO: Assistant Commissioner for Patents Box Patent Application Washington, DC 20231
1. <input checked="" type="checkbox"/> Fee Transmittal Form (e.g. PTO/SB/17) <small>(Submit an original and a duplicate for fee processing)</small> 2. <input checked="" type="checkbox"/> Specification Total Pages 19 3. <input checked="" type="checkbox"/> Drawing(s) (35 U.S.C. 113) Total Sheets 4 4. <input type="checkbox"/> Oath or Declaration Total Pages <input type="text"/> a. <input type="checkbox"/> Newly executed (original or copy) b. <input type="checkbox"/> Copy from a prior application (37 C.F.R. §1.63(d)) <small>(for continuation/divisional with box 15 completed)</small> i. <input type="checkbox"/> DELETION OF INVENTOR(S) Signed statement attached deleting inventor(s) named in the prior application, see 37 C.F.R. §1.63(d)(2) and 1.33(b). 5. <input type="checkbox"/> Incorporation By Reference <small>(usable if box 4B is checked)</small> The entire disclosure of the prior application, from which a copy of the oath or declaration is supplied under Box 4B, is considered to be part of the disclosure of the accompanying application and is hereby incorporated by reference therein.	ACCOMPANYING APPLICATION PARTS 6. <input type="checkbox"/> Assignment Papers (cover sheet & document(s)) 7. <input type="checkbox"/> 37 C.F.R. §3.73(b) Statement <input type="checkbox"/> Power of Attorney <small>(when there is an assignee)</small> 8. <input type="checkbox"/> English Translation Document <small>(if applicable)</small> 9. <input type="checkbox"/> Information Disclosure Statement (IDS)/PTO-1449 <input type="checkbox"/> Copies of IDS Citations 10. <input type="checkbox"/> Preliminary Amendment 11. <input checked="" type="checkbox"/> White Advance Serial No. Postcard 12. <input type="checkbox"/> Small Entity Statement(s) <input type="checkbox"/> Statement filed in prior application. Status still proper and desired. 13. <input type="checkbox"/> Certified Copy of Priority Document(s) <small>(if foreign priority is claimed)</small> 14. <input checked="" type="checkbox"/> Other: Notice of Priority, List of Inventors' Names and Addresses
15. If a CONTINUING APPLICATION, check appropriate box, and supply the requisite information below: <input type="checkbox"/> Continuation <input type="checkbox"/> Divisional <input type="checkbox"/> Continuation-in-part (CIP) of prior application no.: Prior application information: Examiner: Group Art Unit:	
16. Amend the specification by inserting before the first line the sentence: <input type="checkbox"/> This application is a <input type="checkbox"/> Continuation <input type="checkbox"/> Division <input type="checkbox"/> Continuation-in-part (CIP) of application Serial No. Filed on <input type="checkbox"/> This application claims priority of provisional application Serial No. Filed	
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**DEVICE FOR MEASURING CHARACTERISTICS OF AN
ELECTROMAGNETIC FIELD, PARTICULARLY FOR THE
RADIATION DIAGRAM OF AN ANTENNA**

5 The present invention relates to a device for measuring the characteristics of an electromagnetic field radiated by a source, in particular the radiation diagram of an antenna emitting within the hyper-frequency range.

10 In order that the present invention may be better understood, and although such cannot be limited to this application only, the invention will be disclosed within the frame of its preferred application, namely measuring the radiation diagram of an antenna, more particularly an antenna used in the
15 very high frequency range.

BACKGROUND OF THE INVENTION

20 The radiation characteristics of an antenna may be determined by measuring the antenna field on an imaginary surface crossed by the radiated power. This measurement surface typically is planar, cylindrical or spherical. Said measures naturally will usually be performed on the user's site.

25 The measuring device generally is called a measure probe. The appended figure 1A schematically illustrates an example of a prior art measure probe.

Such a measure probe 1a essentially includes the following components : a radiating element 13

carried on a support 12 and a probe mount 10. This mount 10 also can act as a support for various electronic circuits for converting and processing the signals received by the probe 1a. The support 12 and the radiating element 13 constitute the probe proper.

The radiating element 13 can have several shapes, depending upon the precise application concerned, the frequency range to be measured, the polarization of the waves emitted by the antenna being tested, etc. Significant examples of the radiating element 13 may be of the slit or dipole type. It should be clearly understood that the word "radiating" indifferently applies to the emission or reception of waves. Finally, the support 2 of the radiating element 13 may be fastened on the mount 10 in an irremovable or a removable manner. The fastening member usually comprises a plate associated with an absorbing element 11a, which will strongly attenuate the received radiation within the range of the frequencies to be measured.

In a well-known manner, determining characteristics of an antenna being tested, such as its radiation diagram for instance, first requires that the measure probe itself be perfectly characterized. Not only a certain number of measuring parameters, but also the probe behavior when immersed in an electromagnetic field, namely need to be known. Even a small size measure probe will not stay "neutral" with respect to the electromagnetic field to be measured. It will interact with it and potentially disturb it.

Characterizing or, in other words, calibrating a measure probe includes determining its radiation

diagram, its polarization properties, its gain, and the input reflection coefficient(s) on the probe port(s).

This procedure usually is performed on a so-called calibration site, different from the site where
 5 a potential user will erect the measure probe. It usually is a high precision measurement site, where all measuring parameters can be mastered. All the measure probe characteristics are then perfectly defined by a calibration data set.

10 The measure probe 1a can then be delivered to a potential user, with its calibration data set, for on site tests of an antenna. If however the performances of the measure probe, after its erection on site, are different from the performance previously determined
 15 during calibration, the reliability of the measured data of the antenna being tested is questionable.

The figure 1B schematically illustrates the characteristics measurement procedure for an antenna 2
 20 on the testing site. The antenna 2 being tested is fixed and emits a radiation with certain determined characteristics, to be measured. The measure probe 1a, on the other hand, is movable in space, on a predetermined surface (a plane for instance), as previously indicated. For this purpose, the measure
 25 probe 1a is mounted on the movable carrying device 3, which is moved along a determined path for scanning the above mentioned surface, advantageously under control of computerized means. The measures performed at each point are recorded and real time processed.

30 A major drift source between performances respectively obtained on the calibration site and the measurement site may be found in the differences in the

erection of the measure probe 1a at both sites. A solution consequently needs to be found, i.e. in practice, arranging an appropriate means that will allow eliminating the harmful influence of the erection
5 of the measure probe 1a.

Eliminating for its major part the influence of the mounting assembly of the probe 1a is relatively simple on the calibration site (figure 1A), just by an appropriate digital processing of the calibration data.
10 As previously indicated, the calibration site characteristics namely are perfectly known, repetitive and mastered. The calibration source characteristics also are well known.

The environmental characteristics however are
15 different for each measurement site (figure 1B). The exact characteristics of the radiation source, i.e. the antenna 2 being tested, by definition are unknown since they precisely are the objects of the measurement. Mainly the carrying device supporting the probe is
20 there normally different from its supporting assembly on the calibration site.

Using the calibration data set as it stands consequently is impossible if high precision measurements are required.

25 Various prior art solutions were proposed as attempts for solving this problem. The figures 2A and 2B illustrate one of those proposed solutions. Elements that are common with those of the previous figures are designated by the same references and will only be
30 described again as needed.

This solution was described in the following documents, which can be advantageously referred to for additional details :

- the article "Accurate gain measurement on small aperture antennas", Franck JENSEN and J. LEMANCZYK, ,
5 "Proceedings of 14th ESA Workshop on Antenna Measurements", WWP-028, May 6-8 1991,

- and the article "The calibration probes for near-field measurements", Franck JENSEN and J. LEMANCZYK,
10 "AMTA Symposium", pp. 9.5-9.10, October 7-11 1991.

As compared with the measure probe 1a of figures 1A and 1B, the present measure probe, now called 1b shows a different structure, essentially because an absorbing element 11b now is an integral
15 part of the measure probe proper. As figure 2A more particularly illustrates, the absorbing element 11b is directly fastened to the support 12, behind the radiating element 13.

As illustrated in figure 2B, an additional
20 fixed absorbent element 14, with a slit 140 that allows the measure probe 101b to be moved on the movable carrying device 3, is provided on the measurement site.

This solution however suffers from a certain number of inconveniences. The absorbing elements namely
25 are made of lightweight and brittle materials. Both a good reproducibility and a stable shape, from the point of view of the electrical properties, consequently are difficult to guarantee.

It is the object of the present invention to
30 overcome the inconveniences of the prior art devices, some of which were just reminded.

SUMMARY OF THE INVENTION

For this purpose, the invention according to a major feature provides means for re-emitting the radiation in a controlled way, instead of an absorbing
5 element for the energy radiated towards the measure probe mount.

This is obtained by using a screen, based on a material that will reflect and re-emit the incident energy, within the range of the wavelength to be
10 measured.

According to another feature of the invention, said screen shape is optimized in order that the energy radiated by said screen may be redistributed along angular directions with large amplitude, for which the
15 nuisances are unimportant.

The measurement site generally comprises an anechoic chamber wherein the antenna to be tested is located. The walls of this chamber are based on an absorbent material, for the electromagnetic waves
20 within the antenna emission frequency range. The screen re-emission angles can be determined in such a way that the re-emitted radiation is directed towards, and absorbed by, the walls of this anechoic chamber.

The invention consequently offers a number of
25 advantages, among which :

- the measure probe mount is not illuminated anymore, since the screen protects it, and it consequently has no influence on the measure probe characteristics ;

- 30

The main object of the invention consequently is a measuring device for measuring characteristics of an electromagnetic field emitted by a source, hereafter designated as being tested, comprising a radiating element, a support for said radiating element, a probe mount on which said support is fastened, and further comprising a screen carried by said support and interposed between said radiating element and said probe mount, said screen being so designed that it is effective to reflect the beams impinging upon it and re-emit them as scattered into space, along diverging directions.

BRIEF DESCRIPTION OF THE DRAWINGS

The invention will now be described in a more detailed manner while referring to the appended drawings, in which :

- figures 1A and 1B schematically illustrate a first example of a measure probe for the characteristics of an electromagnetic field, during a calibration phase and during a measuring phase proper ;

- figures 2A and 2B schematically illustrate a second example of a measure probe for the characteristics of an electromagnetic field, during a calibration phase and during a measuring phase proper ;

- figure 3 schematically illustrates a measure probe structure of the invention ;

- figure 4 illustrates a practical embodiment of a measure probe of the invention ;

- figure 5A is a graph showing the amplitude variation of a measured signal, depending upon the

incident angle of an electromagnetic wave emitted by a source ;

- figures 5B and 5C are enlarged portions of the graph of figure 5A ;

5 - figure 6A is a graph showing the degradations in the probe radiation graph, caused by a withdrawal of the screen, a main characteristic component of the invention ;

10 - figure 6B is a enlarged portion of the graph of figure 5A ;

- and figure 7 is a graph illustrating the directivity of the measure probe, depending upon the frequency, with and without a screen.

DESCRIPTION OF PREFERRED EMBODIMENT

15 The figure 3 schematically illustrates an embodiment of a measure probe of the invention, hereafter designated as 4.

20 This probe, like in the prior art, includes a radiating element 8 carried by a support 6 (of an elongate shape in the described example), which itself is irremovably or removably fastened to a mount 5.

25 If the measure probe 4 is on the measurement site, it is arranged on a movable carrying device 3 and receives the electromagnetic radiation emitted by the antenna 2 being tested.

As previously indicated, all of those components generally are arranged within an anechoic

chamber 9, with walls (partly represented in figure 3) based upon a material substantially absorbent for the waves emitted by the antenna 2.

According to the main feature of the invention, the support 8 is provided with a screen 7. This screen 7 is made of a material reflecting the captured radiation and shaped to re-emit the radiation along angular directions in such a way that the re-emitted beams will not, for their major part, hit the antenna 2 but will be directed towards the absorbing walls 90 of the anechoic chamber 9, where they will be absorbed.

A second function of the screen 7 is to "protect" the support 6, the mount 5 and the movable carrying device 3 against the radiation emitted by the antenna 2, i.e. to exert a screen function proper.

The figure 3 schematically illustrates the operating mode of the invention. Only a thin central beam f_0 , centered on the symmetry axis or central axis Δ of the measure probe 4 is captured by the radiating element 8 of the measure probe 4. In addition to the central beam f_0 , the antenna 2 also emits beams R_1 , R_2 that are angularly located on both sides of the sighting axis Δ but do not diverge enough not to be intercepted by the surface of the screen 7. They are reflected and re-emitted by this screen as diverging beams R'_1 , R'_2 towards the wall 90 of the anechoic chamber 9. The extreme rays of the beam emitted by the antenna 2, for instance the rays R_3 and R_4 in the figure, directed far away from the sighting axis Δ will not be captured by the radiating element 8 nor by the screen 7, so that they will directly hit the walls 90 of the anechoic chamber 9.

A practical embodiment of the measure probe 4 of the invention will now be described. The figure 4 represents a perspective view of such an embodiment. The elements that are common with elements of the previous figures are designated by the same references and will only be described again as needed.

In the described example, the radiating element 8 is an open conic horn receiving the electromagnetic radiation from the antenna 2 along a direction centered on the sighting axis Δ . The support 6 is a wave-guide with a circular cross section around a symmetry axis along the axis Δ . The screen 7 is shaped as a conic metallic skirt, with a circular cross section, concentric with the axis Δ . The cone vortex angle is an acute angle facing the mount 5.

The mount 5 essentially consists of a rectangular metallic plate, for instance specially processed steel, upon which the support 6 is plugged. The plane of this plate 5 is substantially orthogonal to the axis Δ . On its rear part, the plate also supports electronic circuits 5a which are responsive to the waves transmitted by the wave guide support 6 and act as an interface with a conventional (non represented) signal processing circuit. A (non-represented) communication orifice is provided between the output of the wave-guide 6 and the electronic circuit 50.

Due to the encompassing shape of the screen 7, it is clearly ascertainable that only a radiation R with a high incident angle θ with respect to the axis Δ can reach the end of the support 6 (on the side of the mount 5) and/or the mount 5. As previously illustrated in figure 3, the other rays either are captured by the

opening 80 of the horn 8, or hit the external surface 70 of the skirt constituting the screen 7 and are re-emitted along directions forming a substantial angle with the axis Δ . They are thereby scattered along
 5 directions diverging away from the central sighting axis.

In order that the present invention may be better understood, the main dimensions of the measuring device 4 illustrated in figure 4 can be indicated as
 10 follows :

- diameter of the skirt constituting screen 7 (opening facing the antenna) : 268 mm ,
- opening angle of the skirt (towards the rear) with respect to axis Δ : 45 degrees ,
- 15 - skirt wall thickness : 4,0 mm ,
- cumulative length of support 6 (ahead of the skirt) and the horn 8 : 216,8 mm ,
- total length of support 6 : 555 mm ,
- length of horn 8 : 171,81 mm with a 15,6 mm front
 20 flat ,
- outside and inside diameters of horn 8 : 49,0 mm and 46,6 mm ,
- opening angle of the horn : 14,0 degrees with respect of the axis Δ ,
- 25 - outside and inside diameters of the wave-guide : 20,9 mm and 10,9 mm ,

In order to more completely illustrate the advantageous features of the invention, a digital analysis of the behavior of the measure probe 4 of the
 30 invention was performed while illuminating it with a variably incident radiation, in three configurations : namely with the screen 7, without the screen 7, and without the screen 7 and the rear plate (mount).

For this purpose, the measure probe 4 was fixed and illuminated with a remote field standard source and the amplitude of the measured signal was recorded as a function of the ray incidence angle with respect to the axis Δ . The standard source frequency was 27,75 GHz.

Figure 5A is a graph representing the amplitude variation (in dBi) of the measured signal when the incidence angle θ varies from 0 to 180 degrees, with the screen 7, and without the screen 7 and the rear plate 5, respectively. The graph of figure 5A more precisely represents two sets of curves which are the radiation diagrams corresponding to co-polarization and cross-polarization at 45 degrees : C1 for a measure probe 4 of the invention, with a screen 7 (and a rear plate 5) and C2 with both of these components being withdrawn.

A study of these curves allows ascertaining that the presence of the screen 7 only slightly disturbs the radiation diagram of the measure probe 4 for the values of the angle θ approximately in the range between 80 and 120 degrees. When the angle θ increases, the screen impact is more pronounced.

This conforms with the object of the invention, namely redirecting the energy towards areas located outside the viewing field (as seen from the measure probe) of the antenna being tested.

Figures 5B and 5C are enlarged portions of the figure 5A, wherein the angle θ ranges between 0 and 60 degrees and between 75 and 125 degrees, respectively.

The set of curves C3 of the figure 6A shows the radiation diagram degradations caused by a withdrawal

of the screen 7 and a direct illumination of the mount 5. For comparison purposes, the set of curves C2 (without screen 7 and rear plate 5) also is plotted on this diagram. When the incident angle is small, the radiation influence is very strong, even on the shape of the main beam showing co-polarization.

The figure 6B is an enlarged portion of figure 6A wherein the angle θ ranges between 0 and 60 degrees.

The figure 7 is a graph illustrating the directivity variation of the measure probe 4 as a function of the frequency of the captured radiation, for two different configurations : with the screen 7 (curve C4) and without the screen 7 but with the rear plate 5 (curve C5). The scanning frequency range extends from 26 to 31 GHz. The directivity is expressed in dBi.

Strong oscillations are ascertained when only the rear plate 5 is present (curve C5). Those oscillations are strongly attenuated when the screen 7 is present. This results in much smoother frequency variations, one of the advantages of the invention. As previously indicated, calibrating the measure probe 4 according to the present invention does not require any fine frequency increments.

Upon reading the above, it easily can be ascertained that the invention does reach its object.

It namely offers many advantages. While avoiding repeating all of those advantages previously stated in the introduction of the present description, let us mention the facts that the mount of the measure probe does not any longer influence the probe

characteristics, due to the very arrangements of the invention, in particular because the measure probe no longer is illuminated. Those characteristics do not any longer depend upon the precise probe erection mode on the measurement site. The measure probe structure is strong and its operation will stay stable in normal operating conditions. Its structure and components are compatible with the conventionally used technologies for this type of application. The specific arrangements of the invention do not lead to any substantial cost increase, nor do they induce a larger complexity. They also allow simplifying the calibration procedures by decreasing the number of measure points required dependant upon the frequency.

It should however be clear that the invention is not in any way limited to the only embodiments that were explicitly described, in particular in relation with figures 3 to 7. In particular, all numeric values only were given for a better understanding of the invention. They in fact essentially depend upon the precise application concerned, notably upon the frequency of the antenna to be tested. The same is true about the materials used.

CLAIMS

1. A probe device for measuring characteristics of an electromagnetic field radiated by an electromagnetic source under test, said device comprising a radiating element, a support for said radiating element, and a probe mount on which said support is fastened, and further comprising a screen carried by said support and interposed between said radiating element and said probe mount for reflecting the beams impinging upon it from said source under test so as to re-emit and scatter them as diverging beams into space.

2. A probe device as claimed in claim 1, wherein said screen is shaped and arranged around a central axis of symmetry also constituting a sighting axis for said radiating element when pointing the measuring device along determined measuring directions so that said screen is effective to then direct said diverging beams away from said central axis.

3. A probe device as claimed in claim 1, wherein said screen is so shaped that when said electromagnetic radiation source under test is disposed on a measurement site comprising an anechoic chamber enclosing said source and said device within walls made of a material absorbing the wave lengths associated with the electromagnetic radiations from said source and said device is used as a measuring probe device for determining the characteristics of said source under test, said diverging beams re-emitted by said screen are directed towards said absorbing walls.

4. A probe device as claimed in claim 1, as associated with a movable carrying device for supporting and moving it to scan a predetermined surface when it is used as a measuring probe device for
5 determining the characteristics of said source under test and the latter is fixed.

5. A probe device as claimed in claim 4, wherein said predetermined surface is planar.

6. A probe device as claimed in claim 4,
10 wherein said predetermined surface is cylindrical.

7. A probe device as claimed in claim 1, wherein said screen is shaped and arranged around a central axis of symmetry to be effective to direct said diverging beams away from said central axis, said
15 radiating element is a conical horn, said support is a wave guide with a circular cross section arranged as an extension of said conical horn with same central axis of symmetry, and said mount is a rectangular plate transverse to said central axis.

20 8. A probe device as claimed in claim 7, wherein said screen is a conic skirt having a circular cross section around said axis, inclined by an acute angle with respect to said central axis towards said probe mount.

25 9. A probe device as claimed in claim 8, wherein said acute angle equals 45 degrees.

30 10. A probe device as claimed in claim 7, wherein said radiating element, said support, said probe mount, and said screen are made of a metallic material.

ABSTRACT

DEVICE FOR MEASURING CHARACTERISTICS OF AN
ELECTROMAGNETIC FIELD, PARTICULARLY FOR THE
RADIATION DIAGRAM OF AN ANTENNA

5 The present invention relates to a device, for
measuring characteristics of an electromagnetic field
emitted by a source being tested, comprising a
radiating element (8), a support (6) for said radiating
element and a mount (5) on which said support is
10 fastened. It is characterized in that it comprises a
screen (7) carried by said support (6) and interposed
between said radiating element (8) and said mount (5),
and in that said screen (7) is adapted to reflect the
beams (R_1 , R_2) impinging upon it so as to re-emit and
15 scatter them into space, along determined directions
(R'_1 , R'_2). In the measuring device wherein said
radiating element (8) is associated with the sighting
axis (Δ), so as to point the measuring device (4) along
determined measuring directions, said screen (7) can be
20 shaped such that said determined directions (R'_1 , R'_2)
include large amplitude angles with said sighting axis
(Δ). The measurement site can comprise an anechoic
chamber (9) enclosing said source and having walls
(90).

25 Fig. 4

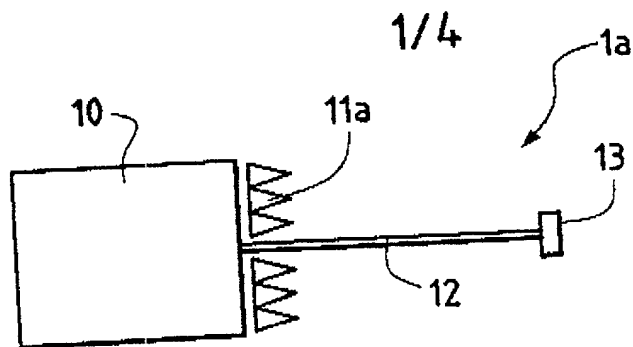


FIG. 1A

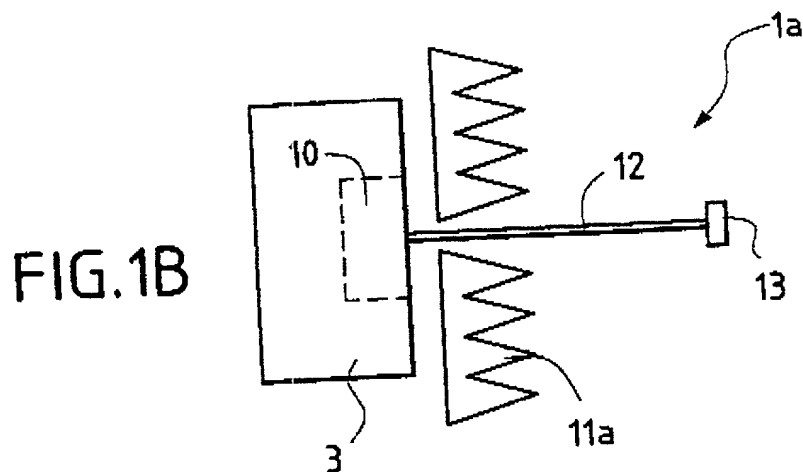


FIG. 1B

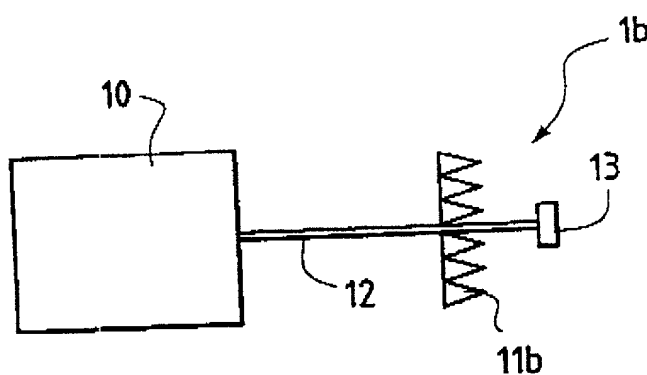


FIG. 2A

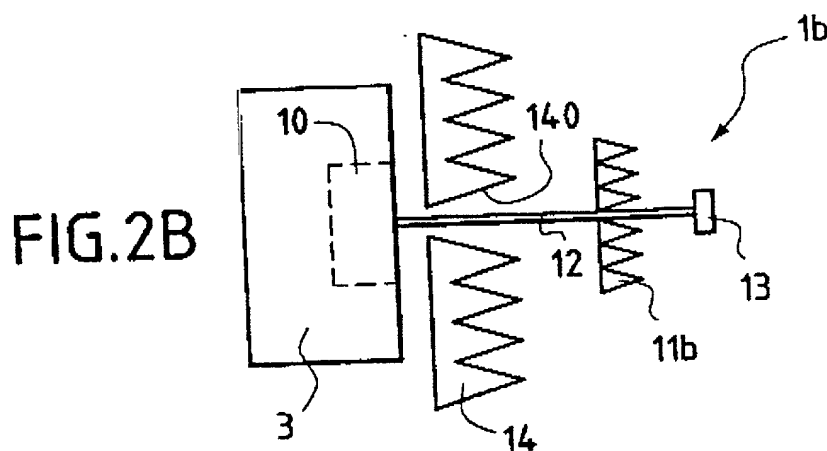


FIG. 2B

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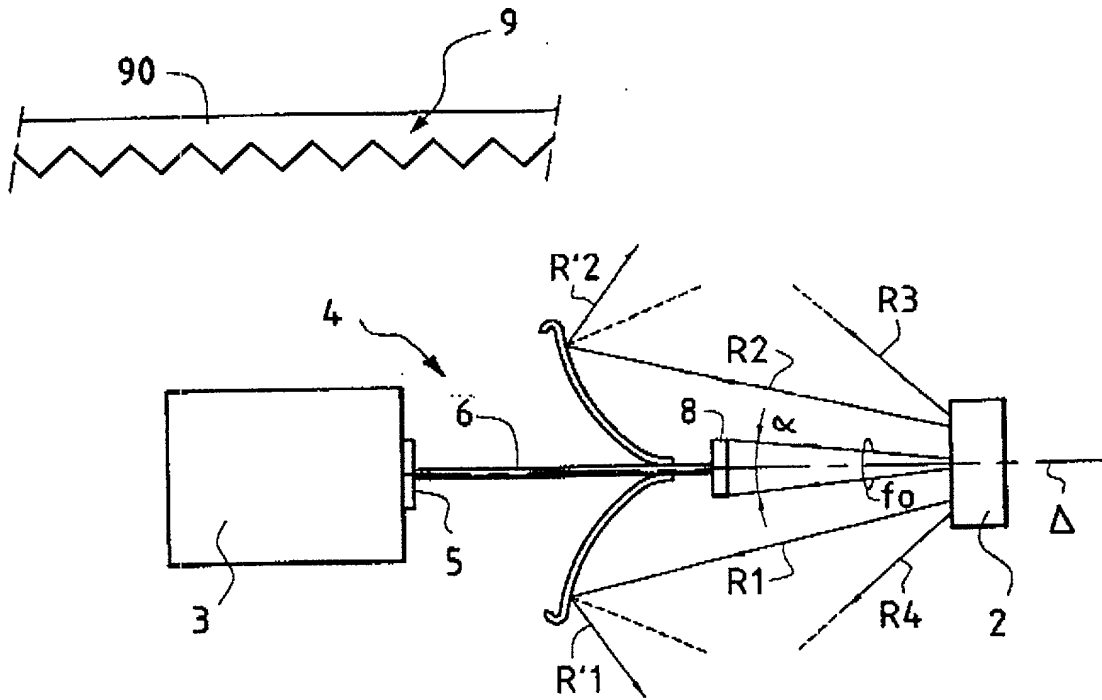


FIG. 3

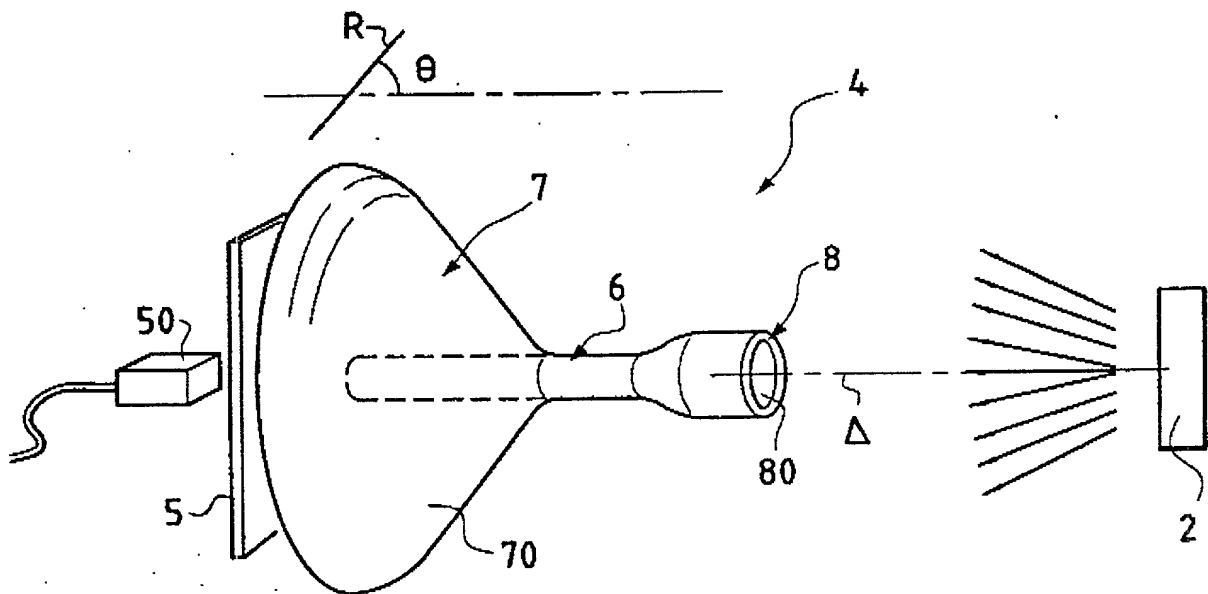


FIG. 4

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FIG.5A

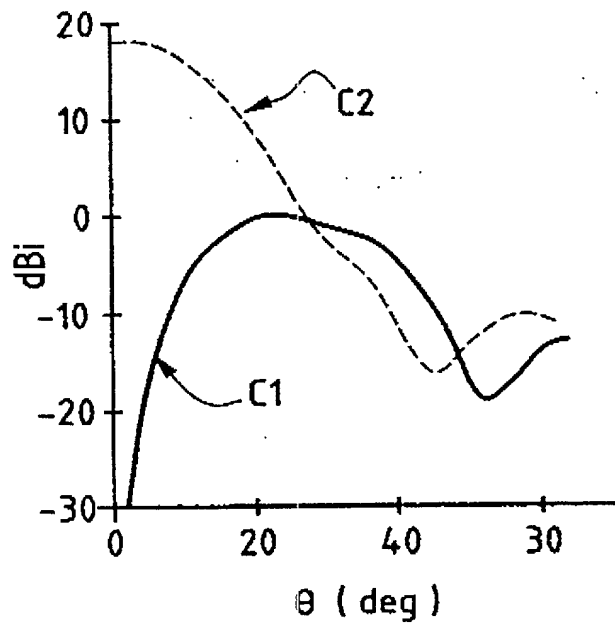
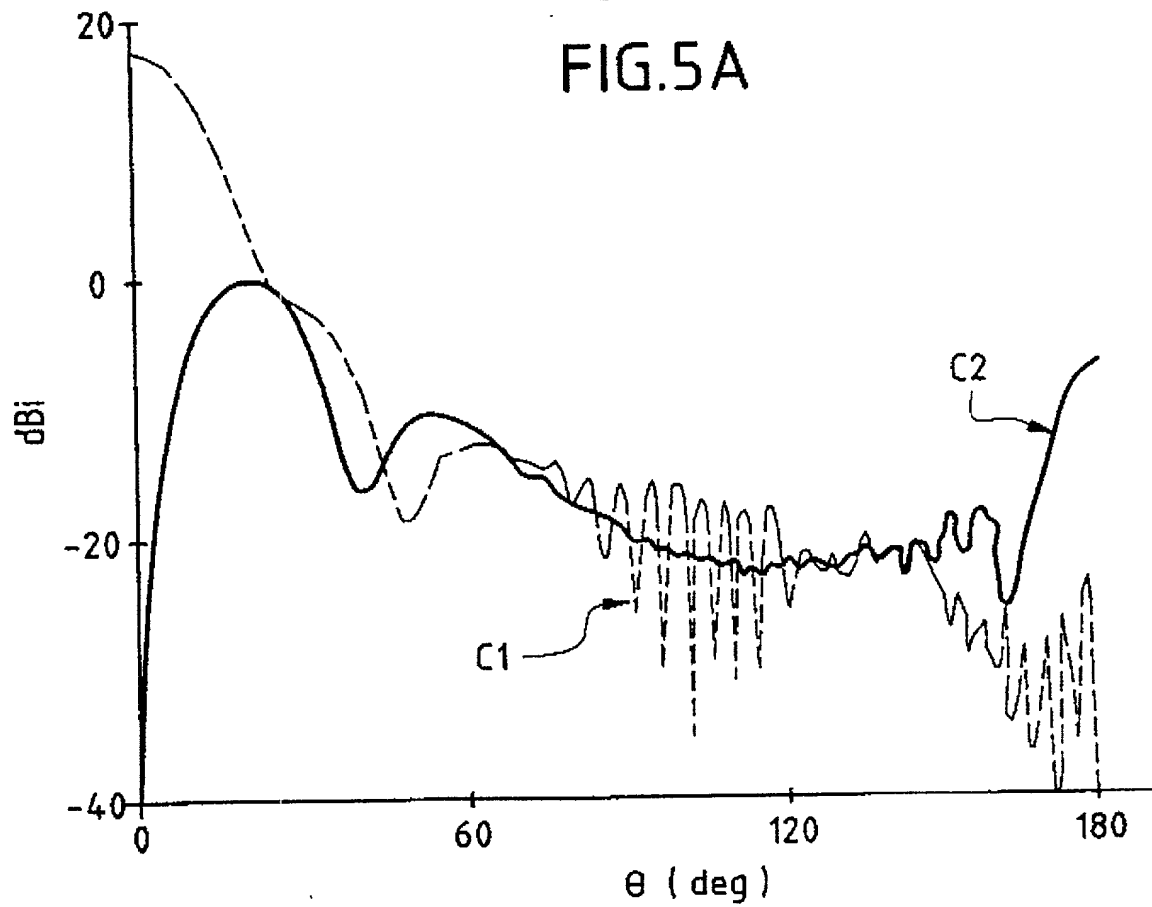


FIG.5B

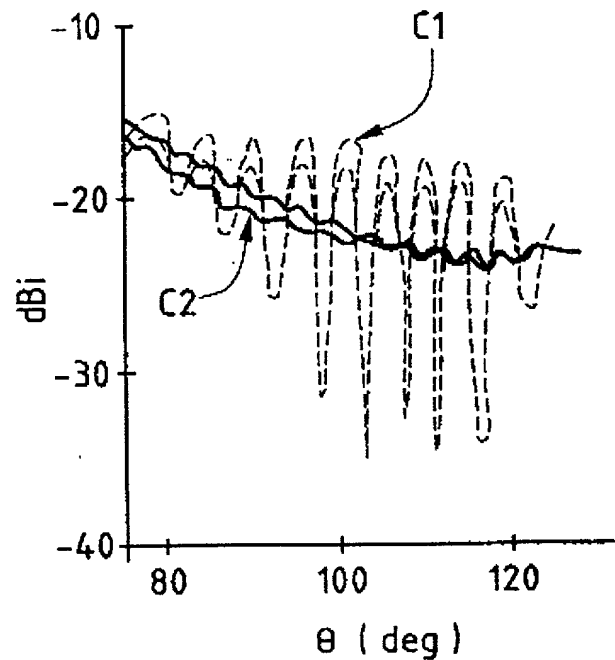


FIG.5C

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FIG.6A

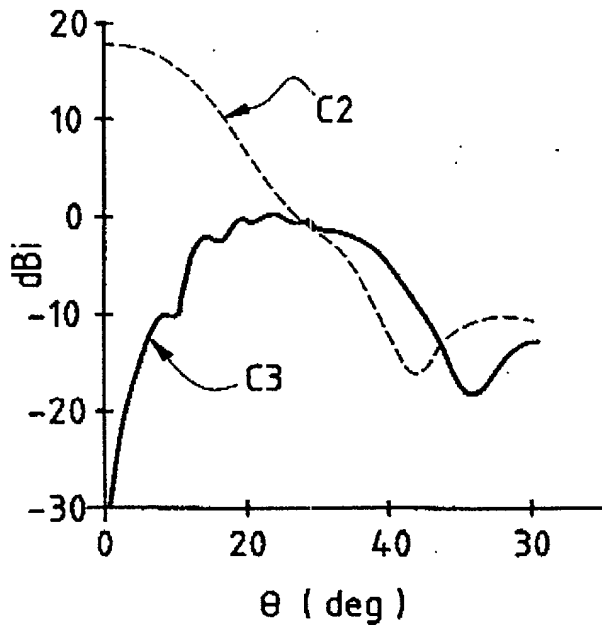
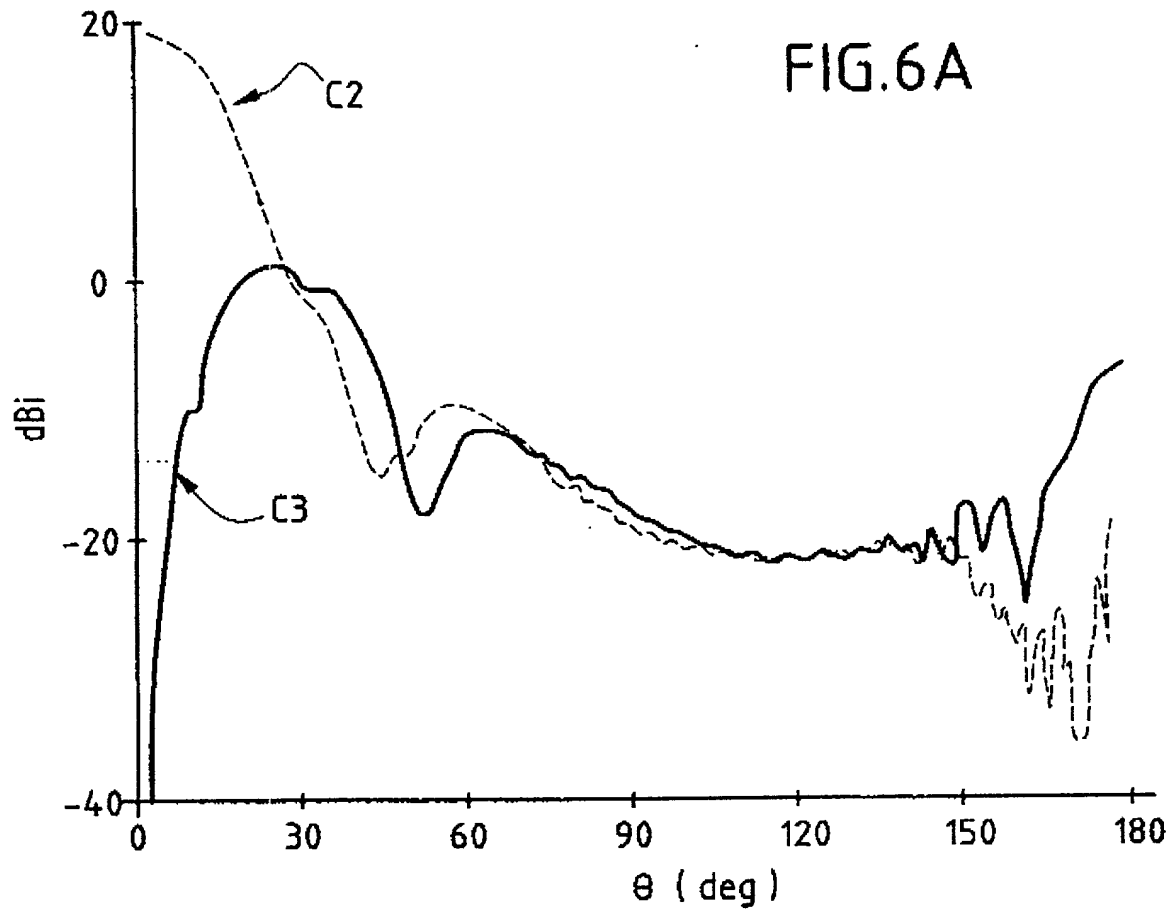


FIG.6B

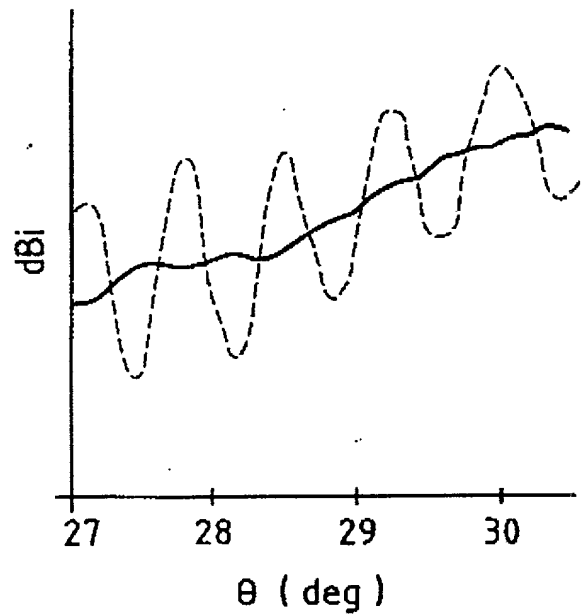


FIG.7

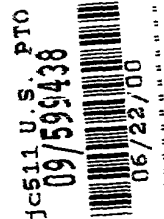
Docket No. 193337US2

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Jerzy M. LEMANCZYK, et al.

FILING DATE: Herewith

FOR: DEVICE FOR MEASURING CHARACTERISTICS OF AN ELECTROMAGNETIC FIELD,
PARTICULARLY FOR THE RADIATION DIAGRAM OF AN ANTENNA



LIST OF INVENTORS' NAMES AND ADDRESSES

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A declaration containing all the necessary information will be submitted at a later date.

Respectfully Submitted,

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